

FF2 S. HOOVER 7/31/01

(2-92)

Sheet 1 of 1

Form PTO-1449 INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>(Use several sheets if necessary)</i>							Docket Number (Optional) 1320-050	Application Number
							Applicant David Walter Rose	
							Filing Date Herewith	Group Art Unit

S-09/864105
05/23/01**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER						DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TCL	5	4	8	7	0	0	6	1/23/96	Kakizaki et al.	364	424.05
	5	8	2	9	1	4	9	11/3/98	Tyson	33	523
	6	1	6	1	4	2	9	12/19/00	Marvel et al.	73	146
	5	7	7	4	3	7	4	6/30/98	Scott et al.	364	561

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

TCL	"A Close Look At Road Surfaces" by Rudolph R. Hegmon, Public Roads On-Line (Summer 1993), pgs. 1-9.
	"Light Weight Profiler", by International Cybernetics Corporation, www.intlcybernetics.com/ltprofile.htm , 7 February 2001, pgs. 1-2.
	"Full Size Profiler", by International Cybernetics Corporation, www.intlcybernetics.com/fsprofile.htm , 7 February 2001, pgs. 1-2.
	www.umtri.umich.edu/erd/roughness/index.html Road Roughness Home Page, 17 March 1998, page 1.
	www.umtri.umich.edu/erd/roughness/iri.html International Roughness, 17 March 1998, pgs 1 – 6.
	www.umtri.umich.edu/erd/roughness/rn.html Ride Number, 17 March 1998, pgs 1 – 5.
	www.umtri.umich.edu/erd/roughness/rtrrms.html Response-Type Road Roughness Measuring Systems, 17 March 1998, pgs 1 – 2.
	"The Little Book of Profiling", By Michael W. Sayers et al., September 1998, 100 pages.

EXAMINER

DATE CONSIDERED

04/23/04

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609-. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.